



Attorney Docket No.: E20020180-D2

Substitute for form 1449A/PTO				<b>Complete if Known</b>	
<b>Information Disclosure Statement By Applicant</b>				Application Number	10/635,271
				Filing Date	August 6, 2003
				First Named Inventor	Kalyan P. Gokhale et al.
				Group Art Unit	2832
(use as many sheets as necessary)				Examiner Name	Tuyen T. Nguyen
Sheet	1	of	1	Attorney Docket Number	E20020180-D2

U.S. PATENT DOCUMENTS						
Examiner Initials <sup>*</sup>	Cite No. <sup>1</sup>	U.S. Patent Document Number Code <sup>2</sup> (if known)	Kind	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
TTN		4,222,096	Patent	Capewell	09/09/1980	
		4,914,559	Patent	Deisch	04/03/1990	
		5,559,396	Patent	Bruning et al.	09/24/1996	
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		US2003/0227363 A1	Publication	Leisten et al.	12/11/2003	
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FOREIGN PATENT DOCUMENTS						
Examiner Initials <sup>*</sup>	Cite No. <sup>1</sup>	Foreign Patent Document Office <sup>3</sup> Number <sup>4</sup> Code <sup>5</sup> (if known)	Kind	Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
TTN		PCT/US03/26583	PCT-ISR	ABB Inc.	08/26/2003	
		08316039	Japan - EP Publication	Kenji	11/29/1996	
		0 577 334 A2	EP	Apurba	06/24/1993	
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<b>Examiner Signature</b>	<i>Tuyen T. Nguyen</i>	<b>Date Considered</b>	<i>8/19/04</i>
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<sup>1</sup>Unique citation designation number. <sup>2</sup>See attached Kinds of U.S. Patent Documents. <sup>3</sup>Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). <sup>4</sup>For Japanese patent documents; the indication of the year of the reign of the Emperor must precede the serial number of the patent document. <sup>5</sup>Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. <sup>6</sup>Applicant is to place a check mark here if English language Translation is attached.